

Search Notes

Application/Control No.

10/535,056

Examiner

Patricia T. Nguyen

Applicant(s)/Patent under
Reexamination

LEYTEN ET AL.

Art Unit

2817

SEARCHED

Class	Subclass	Date	Examiner
330	43	12/27/2006	PN
	53		
	54		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST		